## Applicant(s)/Patent Under Application/Control No. Reexamination 09/467,851 LEAK ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 2623 Hai Tran **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY US-2004/0261130 12-2004 Leak et al. 725/136 Α US-В С US-US-D US-Е US-F US-G US-Н US-US-J US-Κ US-L US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

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